

Notice of References Cited	Application/Control No. 10/786,618	Applicant(s)/Patent Under Reexamination ICHIHARA ET AL.	
	Examiner Marcus Charles	Art Unit 3682	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,007,781	03-2006	Ichihara et al.	192/48.92
*	B	US-6,617,727	09-2003	Iwasa et al.	310/75R
*	C	US-6,234,769	05-2001	Sakai et al.	417/374
*	D	US-6,993,910	02-2006	Iwanami et al.	60/645
*	E	US-2002/0157413	10-2002	Iwanami et al.	62/236
*	F	US-2003/0103848	06-2003	Hayashi, Hirohito	417/212
*	G	US-6,640,948	11-2003	Shirataki et al.	192/45
*	H	US-2003/0141161	07-2003	Ouchi, Hideo	192/45
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP (05-60153) A ✓	03-1993	Japan	Iga et al.	192/45
	O	JP (2001-140757) (A) ✓	05-2001	Japan	--	F04B 35/00
	P	DE (10317522) A1 ✓	11-2003	Germany	Iwanami et al.	F04B 35/04
	Q	JP (2000-274456) A	10-2000	Japan	Fujiwara et al.	F16D 41/06
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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